Applicant(s)/Patent Under Application/Control No. Reexamination 10/658,630 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2617 Simon A. Goetze **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * 359/173 US-2002/0048071 04-2002 Suzuki et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J

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